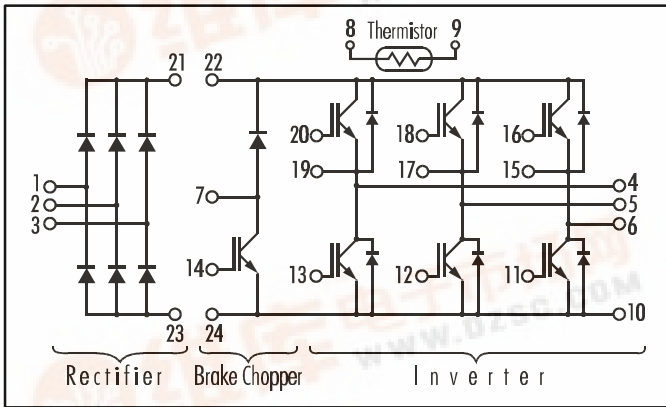


Power Integrated Module (PIM)

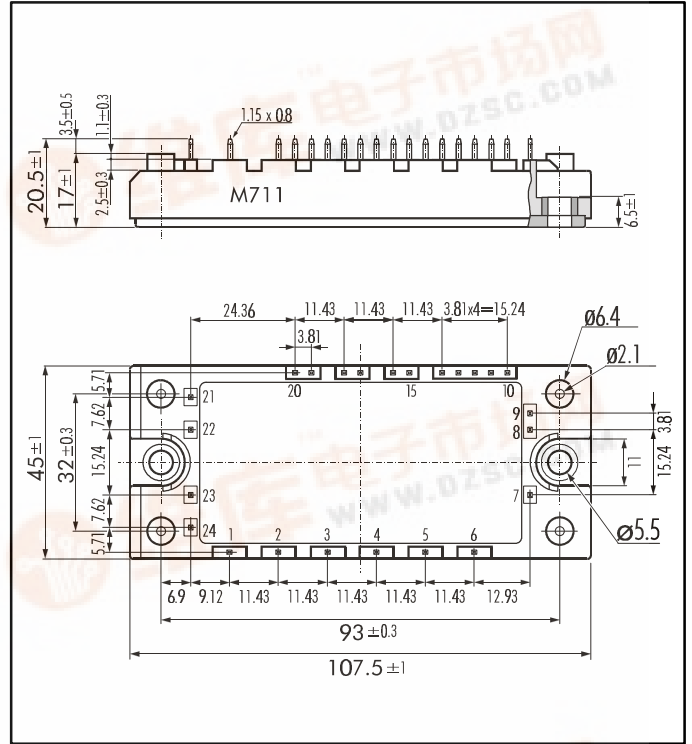
■ Features

- PT-Technology
- Solderable Package
- High Short Circuit Withstand-Capability
- Small Temperature Dependence of the Turn-Off Switching Loss
- Low Losses And Soft Switching

■ Equivalent Circuit



■ Outline Drawing



■ Absolute Maximum Ratings (T_c=25°C)

	Items	Symbols	Test Conditions	Ratings	Units	
Inverter	Collector-Emitter Voltage	V _{CES}		600	V	
	Gate -Emitter Voltage	V _{GES}		± 20		
	Collector Current	I _C		Continuous	50	A
		I _{C PULSE}		1ms	100	
		-I _{C PULSE}			50	
Collector Power Dissipation	P _C		1 device	200	W	
Rectifier	Repetitive Peak Reverse Voltage	V _{RRM}		800	V	
	Average Output Current	I _O	50Hz/60Hz sinus wave	50	A	
	Surge Current (Non Repetitive)	I _{FSM}	T _j =150°C, 10 ms, sinus wave	350		
	I ² t (Non Repetitive)			613	A ² s	
Brake Chopper	Collector-Emitter Voltage	V _{CES}		600	V	
	Gate -Emitter Voltage	V _{GES}		± 20		
	Collector Current	I _C		Continuous	30	A
		I _{C PULSE}		1ms	60	
	Collector Power Dissipation	P _C		1 device	120	W
	Repetitive Peak Reverse Voltage	V _{RRM}			600	V
Operating Junction Temperature	T _j			+150	°C	
Storage Temperature	T _{Stg}			-40 ~ +125		
Isolation Voltage	V _{ISO}		A.C. 1min.	2500	V	
Mounting Screw Torque*				3.5	Nm	

Note: *:Recommendable Value; 2.5 ~ 3.5 Nm (M5)



■ Electrical Characteristics (T_j=25°C)

Items		Symbols	Test Conditions	Min.	Typ.	Max.	Units	
Inverter	IGBT	Zero Gate Voltage Collector Current	I _{CES}	V _{GE} =0V V _{CE} =600V		1.0	mA	
		Gate-Emitter Leakage Current	I _{GES}	V _{CE} =0V V _{GE} =±20V		200	nA	
		Gate-Emitter Threshold Voltage	V _{GE(th)}	V _{GE} =20V I _C =50mA	5.5	7.8	8.5	V
		Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} =15V I _C = 50A	Chip	1.8		
					Terminal	1.95	2.40	
	Input Capacitance	C _{ies}	f=1MHz, V _{GE} =0V, V _{CE} =10V		5000		pF	
	Turn-on Time	t _{on}	V _{CC} = 300V			0.45	1.2	μs
		t _{r,x}	I _C = 50A			0.25	0.6	
		t _{r,i}	V _{GE} = ±15V			0.08		
		t _{off}	R _G = 51Ω			0.40	1.0	
t _f		Inductive Load			0.05	0.35		
FRD	Diode Forward On-Voltage	V _F	I _F =50A	Chip	1.75		V	
				Terminal	1.9	2.6		
	Reverse Recovery Time	t _{rr}	I _F =50A			300	ns	
Rectifier	Forward Voltage	V _{FM}	I _F =50A	Chip	1.1		V	
				Terminal	1.2	1.5		
	Reverse Current	I _{RRM}	V _R =800V			1.0	mA	
Brake Chopper	Zero Gate Voltage Collector Current	I _{CES}	V _{GE} =0V V _{CE} =600V			1.0	mA	
	Gate-Emitter Leakage Current	I _{GES}	V _{CE} =0V V _{GE} =±20V			200	nA	
	Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} =15V I _C =30A	Chip	1.80			
				Terminal	1.95	2.4		
	Turn-on Time	t _{on}	V _{CC} = 300V			0.45	1.2	
		t _{r,x}	I _C = 30A			0.25	0.6	
		t _{off}	V _{GE} = ±15V			0.40	1.0	
Turn-off Time	t _f	R _G = 82Ω			0.05	0.35		
	Reverse Current	I _{RRM}	V _R =600V			1.0	mA	
NTC	Resistance	R	T= 25°C		5000		Ω	
			T=100°C	465	495	520		
	B Value	B	T=25 / 50°C	3305	3375	3450	K	

■ Thermal Characteristics

Items	Symbols	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance (1 device)	R _{th(j-c)}	Inverter IGBT			0.63	°C/W
		Inverter FRD			1.33	
		Brake IGBT			1.04	
		Rectifier Diode			2.42	
Contact Thermal Resistance	R _{th(c-f)}	With Thermal Compound		0.05		

